

| | | | | |
|-----------------------------------|--|-------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination HAM ET AL. | |
| | | Examiner Brij B Shrivastav | Art Unit 2859 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| X | A | US-4,535,291 | 08-1985 | Lee et al. | 324/320 |
| X | B | US-5,721,490 | 02-1998 | Takano et al. | 324/322 |
| X | C | US-5,661,401 | 08-1997 | Ishikawa et al. | 324/320 |
| | D | US- | | | |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|----------------|----------------|
| X | N | DE 3328369 A | 07-1984 | DE | Anderson et al | ----- |
| X | O | JP 11221200 | 02-1998 | JP | Yoshiaki | ----- |
| X | P | JP 9266894 | 04-1998 | JP | Munetaka | ----- |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.